Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination				
08/487,623	LOVGREN ET AL.				
Examiner	Art Unit				
Rodnev P. Swartz, Ph.D.	1645				

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Cla	ss	Subclass	s Date		Examiner	
43	5	6 7.1 7.5 7.92-7.95 962 968 973	5/28/1996		cs	
43	6	518				
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		800 814				
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435	7.1,7.5				
435	7.92-7.95				
436/518,	2,968,973; 523-531, 4, 818,825,				

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
consulted parent USSSN 08/182550, Dialog/APS	5/28/1996	CS
Appeals ConfLynette Smith,SPE & Jeffrey Siew, SPE	5/3/2005	RPS